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# PRODUCT DATA

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Micro International, Inc

PART NUMBER

LDTBFR96 and LDTBFR96T

Micro-LID NPN Transistor



Micro International, Inc.  
179-204 Belle Forrest Circle  
Nashville, TN 37221

Tel: 615-662-1200 Fax 615-662-1226

## Micro-LID Transistors LDTBFR96 and LDTBFR96T

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### Description:

The LDTBFR96 (untinned) and LDTBFR96T (tinned) are NPN silicon 5 GHz wideband transistors in very small, rugged, surface mount, 4-post ceramic packages (Micro International manufactured package p/n 4-075-1). The LDTBFR96 and LDTBFR96T meet the general specifications of the BFR96 transistor. The 4-075-1 Micro-LID package is a 4-post, leadless ceramic carrier which can be provided with gold metallized or pre-tinned lands, and is approved for military, medical implant, sensor, and high reliability applications. The LDTBFR96 and LDTBFR96T can be provided with special feature options such as additional temperature cycling, screening, and matching Hfe selection.

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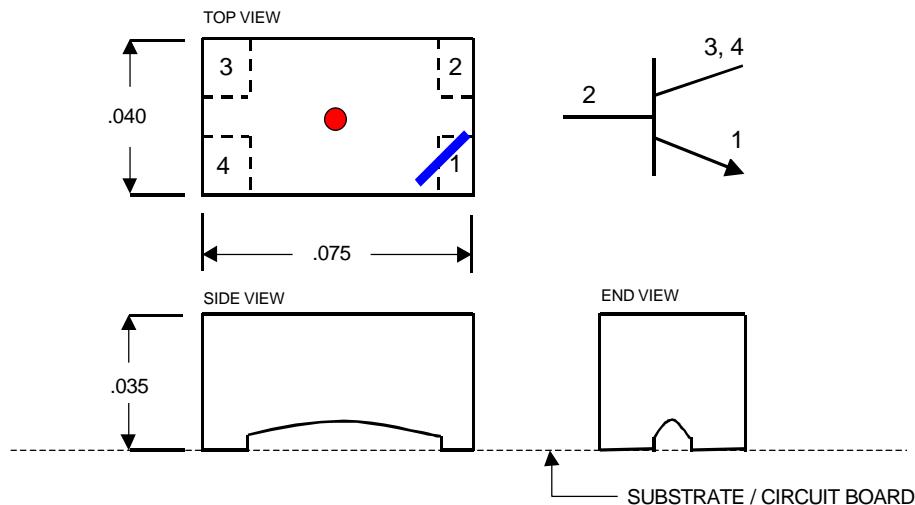
### Maximum Ratings:

Parameter	Symbol	Rating
Collector-Base Voltage	V <sub>cbo</sub>	20 V
Collector-Emitter Voltage	V <sub>ceo</sub>	15 V
Emitter-Base Voltage	V <sub>ebo</sub>	3 V
Collector Current	I <sub>c</sub>	75 mA
Total Dissipation	P <sub>t</sub>	350 mW
Operating Junction Temperature	T <sub>j</sub>	150°C
Storage Temperature	T <sub>stg</sub>	-65°C to 150°C
Operating Temperature	T <sub>oper</sub>	-55°C to 125°C

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## Micro-LID Transistors LDTBFR96 and LDTBFR96T

### Outline / Schematic:



### Dimensions / Marking:

Length	.075" $\pm$ .003"	Post 1 (Emitter)	.015" x .010" typ
Width	.040" $\pm$ .003"	Post 2 (Base)	.015" x .010" typ
Height	.035" $\pm$ .003"	Post 3,4 (Collector)	.015" x .012" typ

Marking on back of package : Blue Diagonal Stripe over Emitter and Red Dot  
(post down configuration) in Center

### Standard In-Process Screening Requirements:

- Semiconductor die and Micro-LID package visual inspection
- Wire pull test
- 24 hour stabilization bake at 150°C
- 10 temperature cycles from -55°C to 125°C
- 100% electrical test of dc characteristics at 25°C
- Final visual inspection

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**Electrical Characteristics (25°C Ambient)**

Parameter	Symbol	Min	Typ	Max	Units
Collector-Base Breakdown Ic = 100 uA, Ie = 0	BVcbo	20	--	--	V
Collector-Emitter Breakdown* Ib = 0, Ic = 10 mA	BVceo	15	--	--	V
Emitter-Base Breakdown Ic = 0, Ie = 100 uA	BVebo	3	--	--	V
Collector-Base Cutoff Current Vcb = 10 V	Icbo	--	--	100	nA
DC Forward Current Gain* Ic = 50 mA, Vce = 10 V	Hfe	25	--	--	
Collector Capacitance Vcb = 10 V, Ie = 0 f = 1 MHz	Cobo	--	--	1.3	pF
Gain Bandwidth Product Ic = 50 mA, Vce = 10 V f = 500 MHz	fT	--	5	--	GHz
Noise Figure Ic = 50 mA, Vce = 10 V f = 500 MHz	NF	--	--	3.3	dB

\* Pulse test, pulse width  $\leq$  300 usec, duty cycle  $\leq$  2%

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